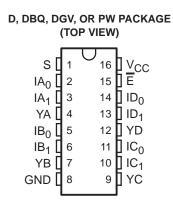
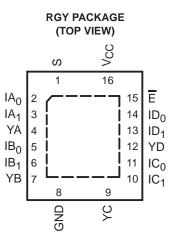
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- Wide Bandwidth (BW = 350 MHz Min)
- Low Differential Crosstalk  $(X_{TALK} = -68 \text{ dB Typ})$
- Low Power Consumption (I<sub>CC</sub> = 10  $\mu$ A Max)
- **Bidirectional Data Flow, With Near-Zero Propagation Delay**
- Low ON-State Resistance ( $r_{on} = 5 \Omega$  Typ)
- Rail-to-Rail Switching on Data I/O Ports  $(0 \text{ to } V_{CC})$
- V<sub>CC</sub> Operating Range From 3 V to 3.6 V
- Ioff Supports Partial-Power-Down Mode Operation



- **Data and Control Inputs Have Undershoot Clamp Diodes**
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- **ESD Performance Tested Per JESD 22** - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)
- Suitable for Both 10 Base-T/100 Base-T Signaling



#### description/ordering information

The TI TS3L100 LAN switch is a 4-bit 1-of-2 multiplexer/demultiplexer with a single switch-enable ( $\overline{E}$ ) input. When  $\overline{E}$  is low, the switch is enabled and the I port is connected to the Y port. When  $\overline{E}$  is high, the switch is disabled and the high-impedance state exists between the I and Y ports. The select (S) input controls the data path of the multiplexer/demultiplexer.

TA	PACKAG	Eţ	ORDERABLE PART NUMBER	TOP-SIDE MARKING							
	QFN – RGY	Tape and reel	TS3L100RGYR	TK100							
		Tube	TS3L100D	TC21 400							
	SOIC – D	Tape and reel	TS3L100DR	TS3L100							
0°C to 70°C	SSOP (QSOP) – DBQ	Tape and reel	TS3L100DBQR	TK100							
		Tube	TS3L100PW	TICADO							
	TSSOP – PW	Tape and reel	TS3L100PWR	TK100							
	TVSOP – DGV	Tape and reel	TS3L100DGVR	TK100							

#### **ORDERING INFORMATION**

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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#### description/ordering information (continued)

This device can be used to replace mechanical relays in LAN applications. This device has low r<sub>on</sub>, wide bandwidth, and low differential crosstalk, making it suitable for 10 Base-T, 100 Base-T, and various other LAN applications.

This device is fully specified for partial-power-down applications using Ioff. The Ioff feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down,  $\overline{E}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

	FUNCTION TABLE										
INPUTS		INPUT/OUTPUT	FUNCTION								
E	S	YX	FUNCTION								
L	L	IX <sub>0</sub>	$YX = IX_0$								
L	Н	IX <sub>1</sub>	$YX = IX_1$								
Н	Х	Z	Disconnect								

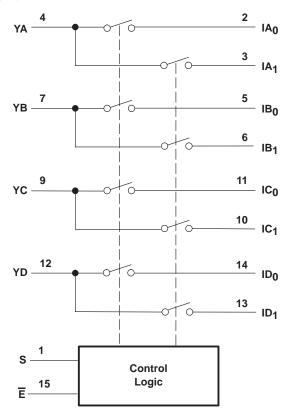
E	S	ΥX	
L	L	IX <sub>0</sub>	$YX = IX_0$
L	Н	IX <sub>1</sub>	$YX = IX_1$
Н	Х	Z	Disconnect

DESCRIPTION
Data I/Os
Select input
Enable input
Data I/Os

#### **PIN DESCRIPTIONS**



### logic diagram (positive logic)





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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub>	–0.5 V to 4.6 V
Control input voltage range, V <sub>IN</sub> (see Notes 1 and 2)	
Switch I/O voltage range, VI/O (see Notes 1, 2, and 3)	
Control input clamp current, I <sub>IK</sub> (V <sub>IN</sub> < 0)	–50 mA
I/O port clamp current, I <sub>I/OK</sub> (V <sub>I/O</sub> < 0)	
ON-state switch current, II/O (see Note 4)	±128 mA
Continuous current through V <sub>CC</sub> or GND terminals	±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 5): D package	
DB package	
DBQ package	
PW package	108°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages are with respect to ground, unless otherwise specified.

- 2. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- 3. VI and V<sub>O</sub> are used to denote specific conditions for  $V_{I/O}$ .
- 4. II and IO are used to denote specific conditions for  $I_{I/O}$ .
- 5. The package thermal impedance is calculated in accordance with JESD 51-7.

#### recommended operating conditions (see Note 6)

		MIN	MAX	UNIT
VCC	Supply voltage	3	3.6	V
VIH	High-level control input voltage (E, S)	2	V <sub>CC</sub>	V
VIL	Low-level control input voltage (E, S)	0	0.8	V
TA	Operating free-air temperature	0	70	°C

NOTE 6: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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PAR	AMETER		TEST COND	ITIONS	MIN	TYP†	MAX	UNIT
VIK	Ē, S	V <sub>CC</sub> = 3 V,	I <sub>IN</sub> = -18 mA				-1.8	V
V <sub>hys</sub>	Ē, S					150		mV
IIН	E, S	V <sub>CC</sub> = 3.6 V,	$V_{IN} = V_{CC}$				±1	μΑ
۱ <sub>IL</sub>	E, S	V <sub>CC</sub> = 3.6 V,	V <sub>IN</sub> = GND				±1	μΑ
I <sub>OZ</sub> ‡		V <sub>CC</sub> = 3.6 V,	$V_{O} = 0$ to 3.6 V, $V_{I} = 0$ ,	Switch OFF			±1	μΑ
los§		V <sub>CC</sub> = 3.6 V,	$V_{O} = 0$ to 0.5 $V_{CC}$ , $V_{I} = 0$ ,	Switch ON	50			mA
loff		V <sub>CC</sub> = 0,	$V_{O} = 0$ to 3.6 V,	$V_{I} = 0$			15	μΑ
ICC		V <sub>CC</sub> = 3.6 V,	$I_{I/O} = 0,$	Switch ON or OFF		0.1	10	μΑ
∆ICC	Ē, S	V <sub>CC</sub> = 3.6 V,	One input at V <sub>CC</sub> – 0.6 V,	Other inputs at $V_{CC}$ or GND			750	μΑ
ICCD		V <sub>CC</sub> = 3.6 V,	I and Y ports open,	V <sub>IN</sub> input switching 50% duty cycle			0.45	mA/ MHz
CIN	Ē, S	f = 1 MHz				3		pF
~	I port		f = 1 MHz,			5		
COFF	Y port	$V_{  } = 0,$	Outputs open,	Switch OFF		10		pF
CON	-	V <sub>I</sub> = 0,	f = 1 MHz, Outputs open,	Switch ON		17		pF
		N	$V_{I} = 0 V,$	I <sub>O</sub> = 48 mA		5	7	0
ron		$V_{CC} = 3 V$	V <sub>I</sub> = 2 V,	I <sub>O</sub> = 15 mA		10	15	Ω
∆r <sub>on</sub>		V <sub>I</sub> = 3 V,	Switch ON,	l <sub>O</sub> = 15 mA		1		Ω

# electrical characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V ± 0.3 V (unless otherwise noted)

VI, VO, II, and IO refer to I/O pins. VIN refers to the control inputs.

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V (unless otherwise noted),  $T_A = 25^{\circ}C$ .

<sup>‡</sup> For I/O ports, the parameter I<sub>OZ</sub> includes the input leakage current.

§ The IOS test is applicable to only one ON channel at a time. The duration of this test is less than one second.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V ± 0.3 V, $R_L$ = 100 $\Omega$ , $C_L$ = 35 pF (unless otherwise noted) (see Figure 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	МАХ	UNIT
tON	S	Y	1	7.5	ns
tOFF	S	Y	1	3.5	ns

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V (unless otherwise noted), T<sub>A</sub> = 25°C.

# dynamic characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS							
X <sub>TALK</sub> (Diff)	R <sub>L</sub> = 100 Ω,	f = 10 MHz, see Figure 8,	$t_r = t_f = 2 \text{ ns}$	-55	dB				
X <sub>TALK</sub>	R <sub>L</sub> = 100 Ω,	f = 30 MHz, see Figure 6		-68	dB				
O <sub>IRR</sub>	R <sub>L</sub> = 100 Ω,	f = 30 MHz, see Figure 7		-42	dB				
BW	$R_L$ = 100 Ω, see Fig	gure 5		350	MHz				

<sup>†</sup> All typical values are at  $V_{CC}$  = 3.3 V (unless otherwise noted),  $T_A$  = 25°C.



# TS3L100 **QUAD SPDT WIDE-BANDWIDTH LAN SWITCH** WITH LOW ON-STATE RESISTANCE SCDS161A - MAY 2004 - REVISED OCTOBER 2004

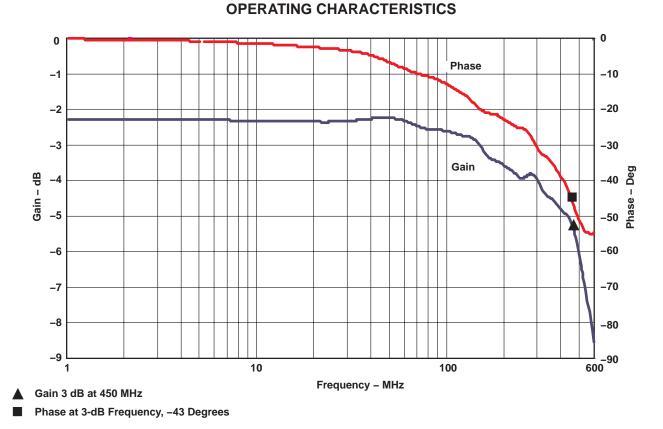


Figure 1. Gain/Phase vs Frequency



## **TS3L100** QUAD SPDT WIDE-BANDWIDTH LAN SWITCH WITH LOW ON-STATE RESISTANCE SCDS161A - MAY 2004 - REVISED OCTOBER 2004

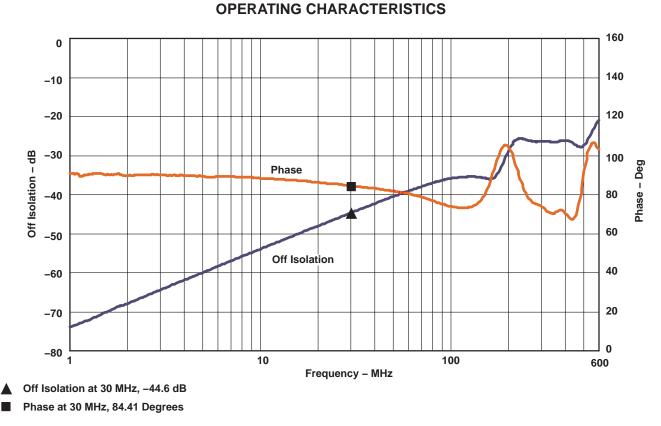


Figure 2. Off Isolation vs Frequency



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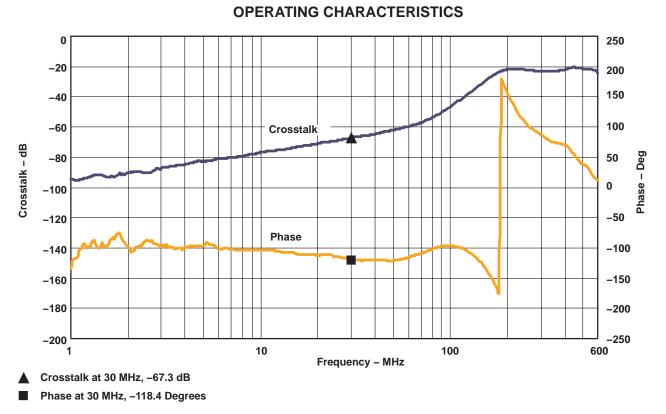
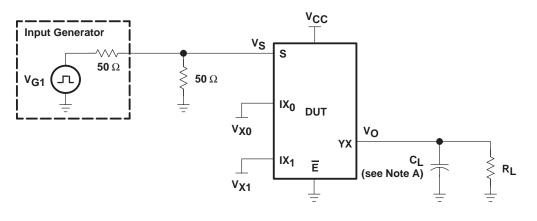


Figure 3. Crosstalk vs Frequency

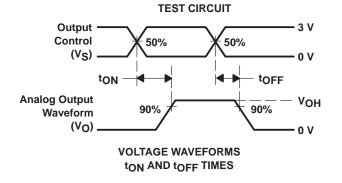


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#### PARAMETER MEASUREMENT INFORMATION



TEST	Vcc	RL	CL	V <sub>X0</sub>	V <sub>X1</sub>
tON	$\begin{array}{c} 3.3 \ V \pm 0.3 \ V \\ 3.3 \ V \pm 0.3 \ V \end{array}$	100 Ω 100 Ω	35 pF 35 pF	GND 3 V	3 V GND
tOFF	$\begin{array}{c} 3.3 \ V \pm 0.3 \ V \\ 3.3 \ V \pm 0.3 \ V \end{array}$	100 Ω 100 Ω	35 pF 35 pF	GND 3 V	3 V GND



NOTES: A. CL includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.
- C. The outputs are measured one at a time, with one transition per measurement.

#### Figure 4. Test Circuit and Voltage Waveforms



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### PARAMETER MEASUREMENT INFORMATION

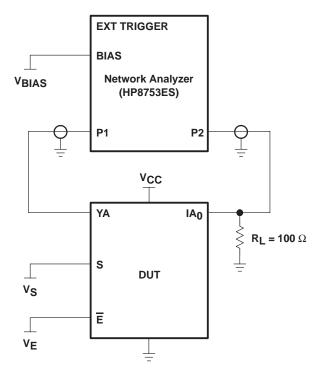


Figure 5. Test Circuit for Frequency Response (BW)

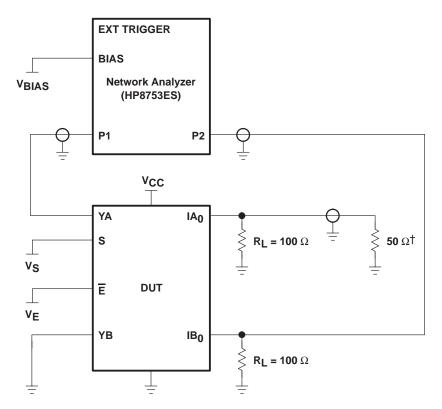
Frequency response is measured at the output of the ON channel. For example, when  $V_S = 0$ ,  $V_E = 0$ , and YA is the input, the output is measured at IA<sub>0</sub>. All unused analog I/O ports are left open.

#### HP8753ES setup

Average = 4RBW = 3 kHz $V_{BIAS} = 0.35 V$ ST = 2 sP1 = 0 dBM



#### PARAMETER MEASUREMENT INFORMATION



 $^{\dagger}$  A 50- $\!\Omega$  termination resistor is needed for the network analyzer.

#### Figure 6. Test Circuit for Crosstalk (XTALK)

Crosstalk is measured at the output of the nonadjacent ON channel. For example, when  $V_S = 0$ ,  $V_E = 0$ , and YA is the input, the output is measured at IB<sub>0</sub>. All unused analog input (Y) ports are connected to GND and output (I) ports are connected to GND through 50- $\Omega$  pulldown resistors.

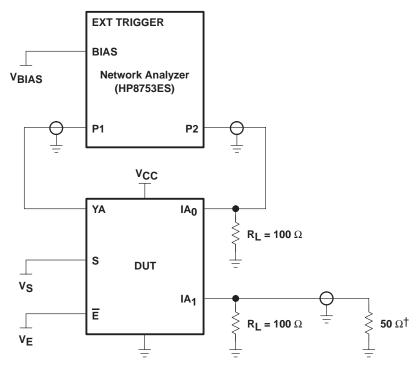
#### HP8753ES setup

Average = 4 RBW = 3 kHz  $V_{BIAS} = 0.35 V$ ST = 2 s P1 = 0 dBM



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#### PARAMETER MEASUREMENT INFORMATION



<sup>†</sup>A 50- $\Omega$  termination resistor is needed for the network analyzer.

#### Figure 7. Test Circuit for Off Isolation (OIRR)

OFF isolation is measured at the output of the OFF channel. For example, when  $V_S = V_{CC}$ ,  $V_E = 0$ , and YA is the input, the output is measured at IA<sub>0</sub>. All unused analog input (Y) ports are left open and output (I) ports are connected to GND through 50- $\Omega$  pulldown resistors.

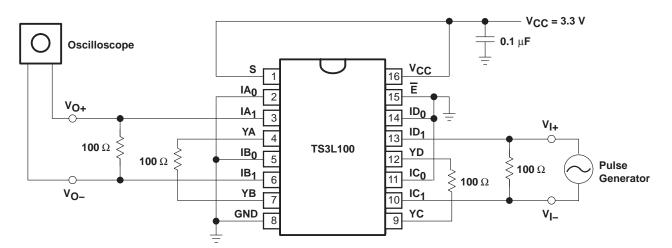
#### HP8753ES setup

Average = 4RBW = 3 kHz $V_{BIAS} = 0.35 V$ ST = 2 s P1 = 0 dBM



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### PARAMETER MEASUREMENT INFORMATION





Differential crosstalk is a measure of coupling noise between a transmit and receive pair in the LAN application. Differential crosstalk depends on the edge rate, frequency, and load. This is calculated from the equation,  $X_{TALK}(Diff) db = 20 \log V_O(Diff)/V_I(Diff)$ , where  $V_O(Diff)$  is the differential output voltage and  $V_I(Diff)$  is the differential input voltage.





10-Jun-2014

### PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
TS3L100DBQR	ACTIVE	SSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	0 to 70	TK100	Samples
TS3L100DGVR	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TK100	Samples
TS3L100DR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TS3L100	Samples
TS3L100PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TK100	Samples
TS3L100PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TK100	Samples
TS3L100PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TK100	Samples
TS3L100PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TK100	Samples
TS3L100RGYR	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	0 to 70	TK100	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



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10-Jun-2014

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE MATERIALS INFORMATION

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#### TAPE AND REEL INFORMATION





### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3L100DBQR	SSOP	DBQ	16	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1
TS3L100DGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
TS3L100DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TS3L100PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TS3L100RGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1

TEXAS INSTRUMENTS

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## PACKAGE MATERIALS INFORMATION

18-Oct-2016



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS3L100DBQR	SSOP	DBQ	16	2500	333.2	345.9	28.6
TS3L100DGVR	TVSOP	DGV	16	2000	367.0	367.0	35.0
TS3L100DR	SOIC	D	16	2500	333.2	345.9	28.6
TS3L100PWR	TSSOP	PW	16	2000	367.0	367.0	35.0
TS3L100RGYR	VQFN	RGY	16	3000	367.0	367.0	35.0

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



4211283-4/E 08/12

# D (R-PDSO-G16) PLASTIC SMALL OUTLINE Stencil Openings (Note D) Example Board Layout (Note C) –16x0,55 -14x1,27 -14x1,27 16x1,50 5,40 5.40 Example Non Soldermask Defined Pad Example Pad Geometry (See Note C) 0,60 .55 Example 1. Solder Mask Opening (See Note E) -0,07 All Around

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



### **MECHANICAL DATA**

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

#### DGV (R-PDSO-G\*\*)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.  $\beta$ . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# **GENERIC PACKAGE VIEW**

### SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



# **DBQ0016A**



# **PACKAGE OUTLINE**

### SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
- This dimension does not include interlead flash.
  Reference JEDEC registration MO-137, variation AB.



# DBQ0016A

# **EXAMPLE BOARD LAYOUT**

### SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DBQ0016A

# **EXAMPLE STENCIL DESIGN**

### SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



### **MECHANICAL DATA**



D. The package thermal pad must be soldered to the board for thermal and mechanical performance.

- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- earrow Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated.
- The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



### RGY (R-PVQFN-N16)

### PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



#### NOTE: All linear dimensions are in millimeters





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.

D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.

- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



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